

10/797, 329

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FORM PTO-1409 (REV. 7-80) (Title Amended 3/83)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. RD29334		SERIAL NO.								
INFORMATION DISCLOSURE STATEMENT BY APPLICANT-- <u>LIST OF ITEMS</u> (Use several sheets if necessary)				Applicant Thomas Watkins Lloyd et al.										
				Filing Date		Group								
U.S. PATENT DOCUMENTS														
EXAMINER INITIAL	DOCUMENT NUMBER			DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE						
AT	AA	4	6	6	8	9	8	2	05/26/87	Timmerino	358	101	06/17/85	
	AB	6	2	0	1	8	8	9	03/13/01	Vannah	382	131	06/18/98	
	AC	4	9	0	8	7	8	2	03/13/90	Pekarek et al.	364	560	05/19/83	
	AD	6	2	4	6	4	6	8	06/12/01	Dimsdale	356	4.02	10/23/98	
	AE	5	9	1	7	9	4	0	06/29/99	Okajima et al.	382	173	01/23/97	
	AF	4	4	8	2	9	7	1	11/13/84	Blazek	364	552	01/18/82	
	AG	5	8	2	8	7	6	9	10/27/98	Burns	382	118	10/23/96	
	AH	5	0	4	7	9	6	6	09/10/91	Crow et al.	364	560	05/22/89	
	AI	5	2	0	8	7	6	3	05/04/93	Hong et al.	364	551.02	09/14/90	
	AJ	5	5	2	1	8	4	7	05/28/96	Ostrowski et al.	264	559	07/01/94	
	AK	5	6	2	7	7	7	1	05/06/97	Makino	364	560	05/06/97	
FOREIGN PATENT DOCUMENTS														
		DOCUMENT NUMBER			DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO					
AT	AL	0	3	8	1	0	6	7	A	01/26/90	European			
	AM													
	AN													
	AO													
	AP													
OTHER INFORMATION (Including Author, Title, Date, Pertinent pages. Etc.)														
AT	AR	G.P. Stein, Accurate Internal Camera Calibration Using Rotation, With Analysis Of Sources Of Error, Artificial Intelligence Lab, MIT, Cambridge, MA 02139, 05/20/1995, pp. 230-236, 0-8186-7042-8/95 1995 IEEE.												
AT	AS	Glenn Healey and Raghava Kondepudy, CCD Camera Calibration and Noise Estimation, Proceedings 1992 IEEE Computer Society Conference on Computer Vision and Pattern Recognition, June 15-18, 1992, Champaign, IL., pp. 90-95.												
AT	AT	Van-Duc Nguyen, Victor Nzomigui and Charles V. Stewart, Fast and Robust Registration of 3D Surfaces Using Low Curvature Patches, Published in International Conference on 3D Imaging and Modeling, Ottawa, October, 1999, pp. 1-8.												
EXAMINER		/Abolfazl Tabatabai/				DATE CONSIDERED		04/21/2007						
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.														

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10/13/07